

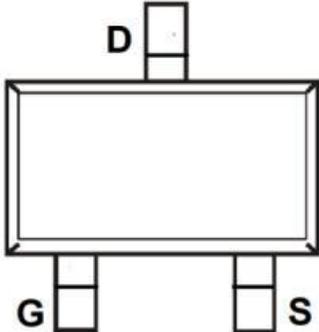
LSR2N10 100V N-Channel MOSFET
Features

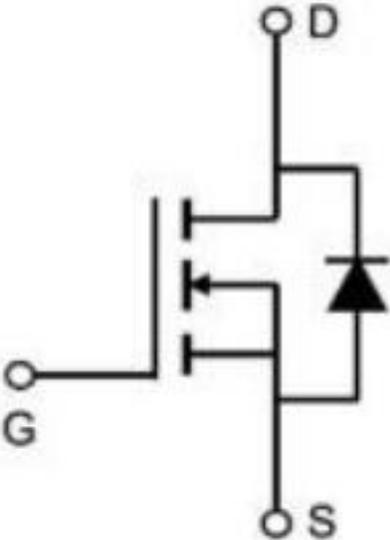
- Advanced SGT MOS technology
- Low Thermal Resistance
- Fast Switching Speed
- Halogen-Free & Lead-Free

Applications

- Load Switch for Portable Device
- Voltage controlled small signal switch

Pin Configuration

LSR2N10(SOT-23)	
 <p>Top View</p>	
Pin	Description
1	Gate
2	Source
3	Drain



Marking Information

Part Marking	Part Number
0102	0102

Absolute Maximum Ratings

 ($T_A=25^{\circ}\text{C}$ Unless otherwise noted)

Symbol	Parameter	Typical	Unit
V_{DSS}	Drain-Source Voltage	100	V
V_{GSS}	Gate-Source Voltage	± 20	V
I_D	Continuous Drain Current ¹	1.75	A
I_{DM}	Pulsed Drain Current ²	8.6	A
P_D	Power Dissipation ¹	1.25	W
T_J	Operating Junction Temperature Range	-55 to +150	$^{\circ}\text{C}$
T_{STG}	Storage Temperature Range	-55 to +150	$^{\circ}\text{C}$
$R_{\theta JC}$	Thermal Resistance-Junction to Lead	19.7	$^{\circ}\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient ¹	100	$^{\circ}\text{C}/\text{W}$

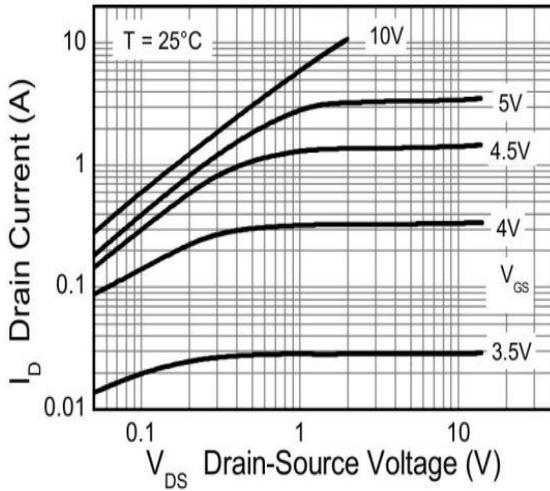
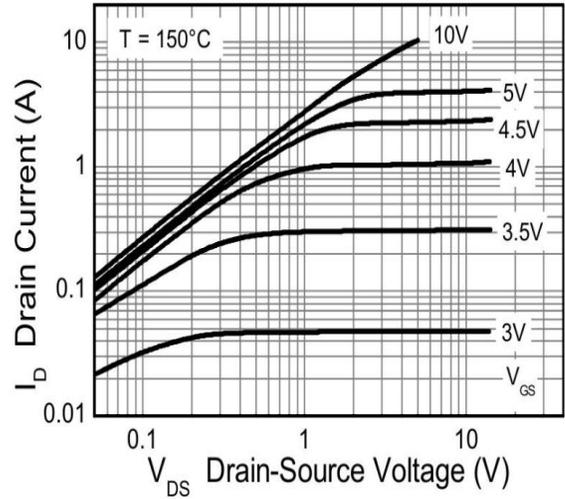
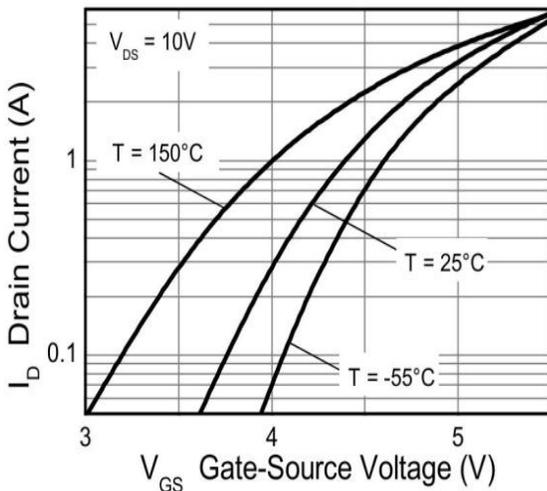
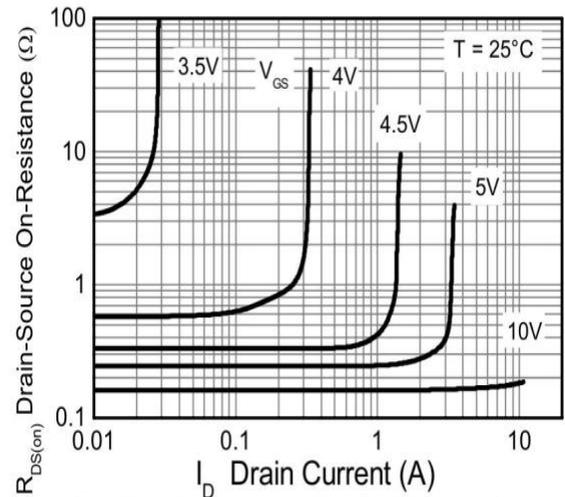
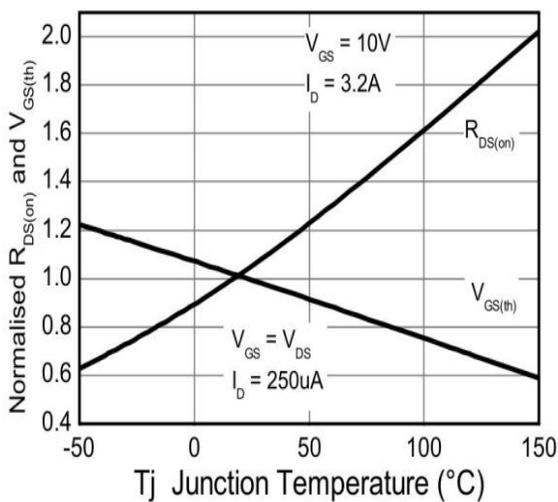
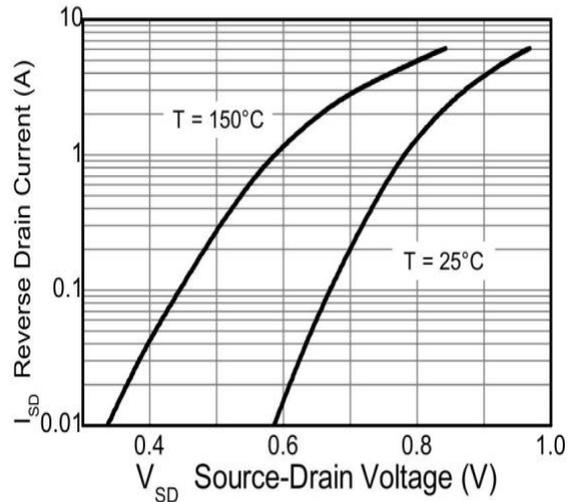
Note:

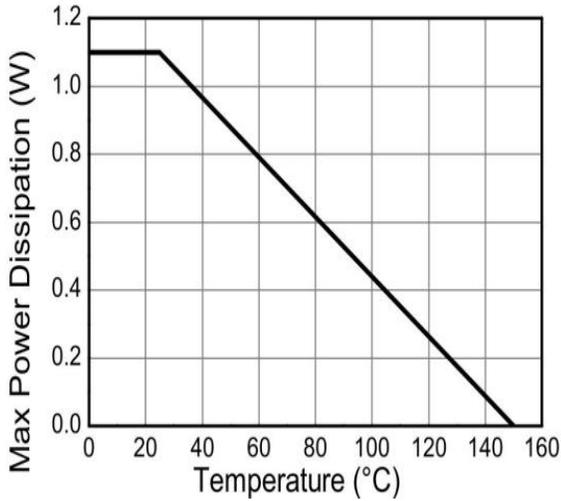
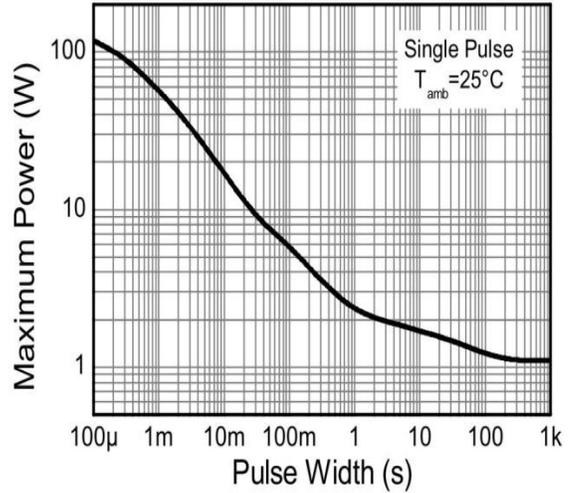
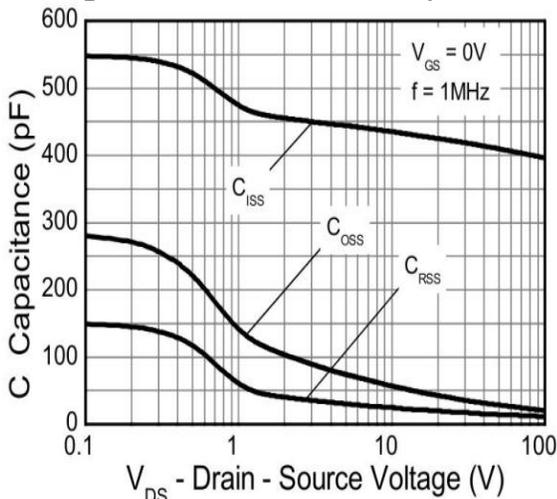
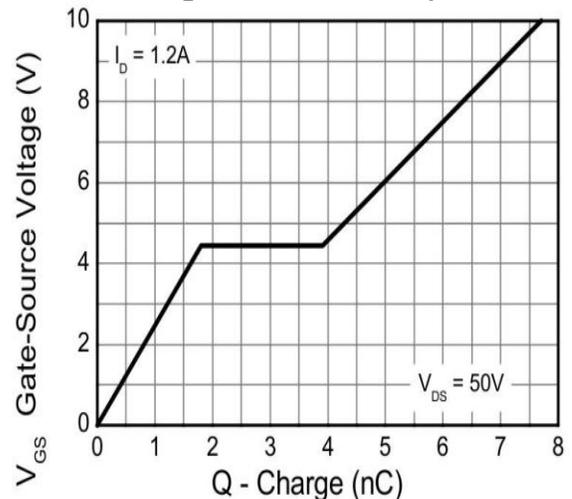
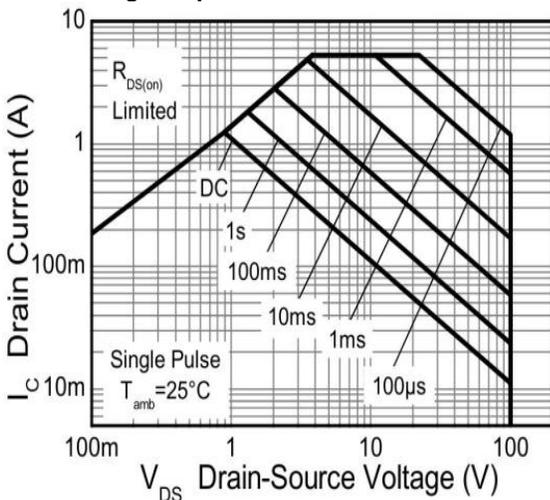
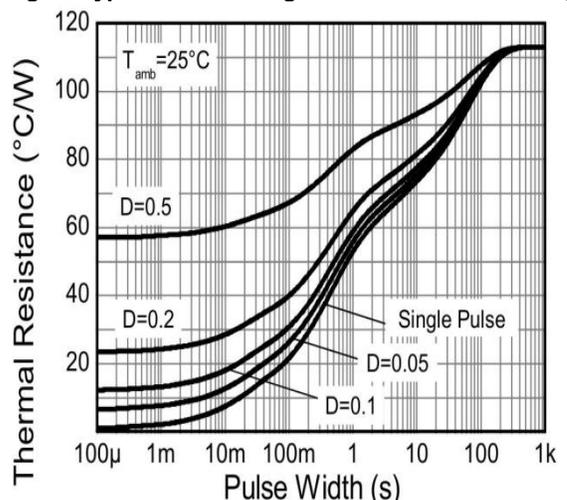
1. For a device surface mounted on 25mm x 25mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.
2. Repetitive rating 25mm x 25mm FR4 PCB, $D = 0.02$, 300us pulse width limited by maximum junction temperature.

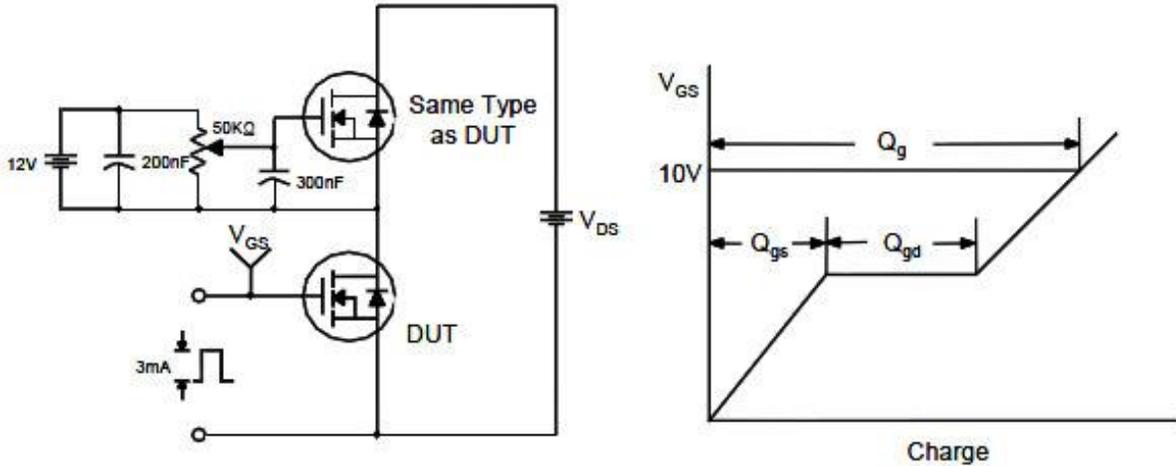
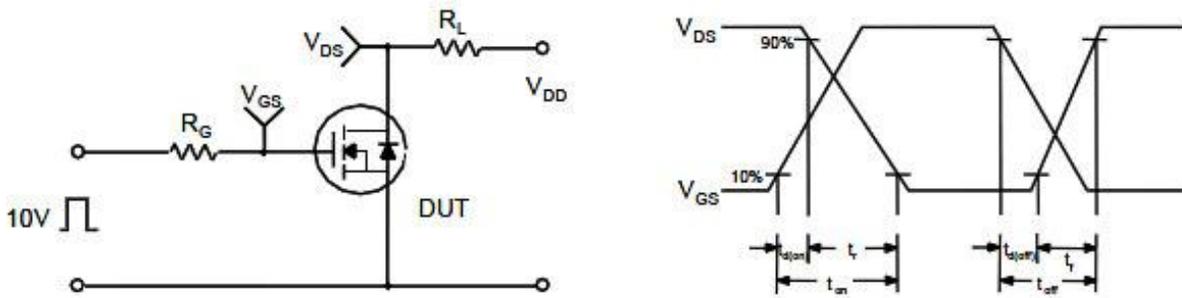
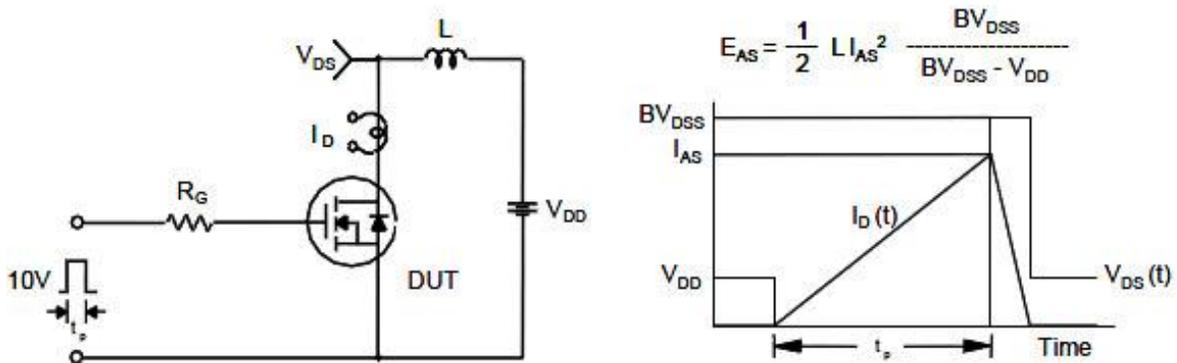
Electrical Characteristics

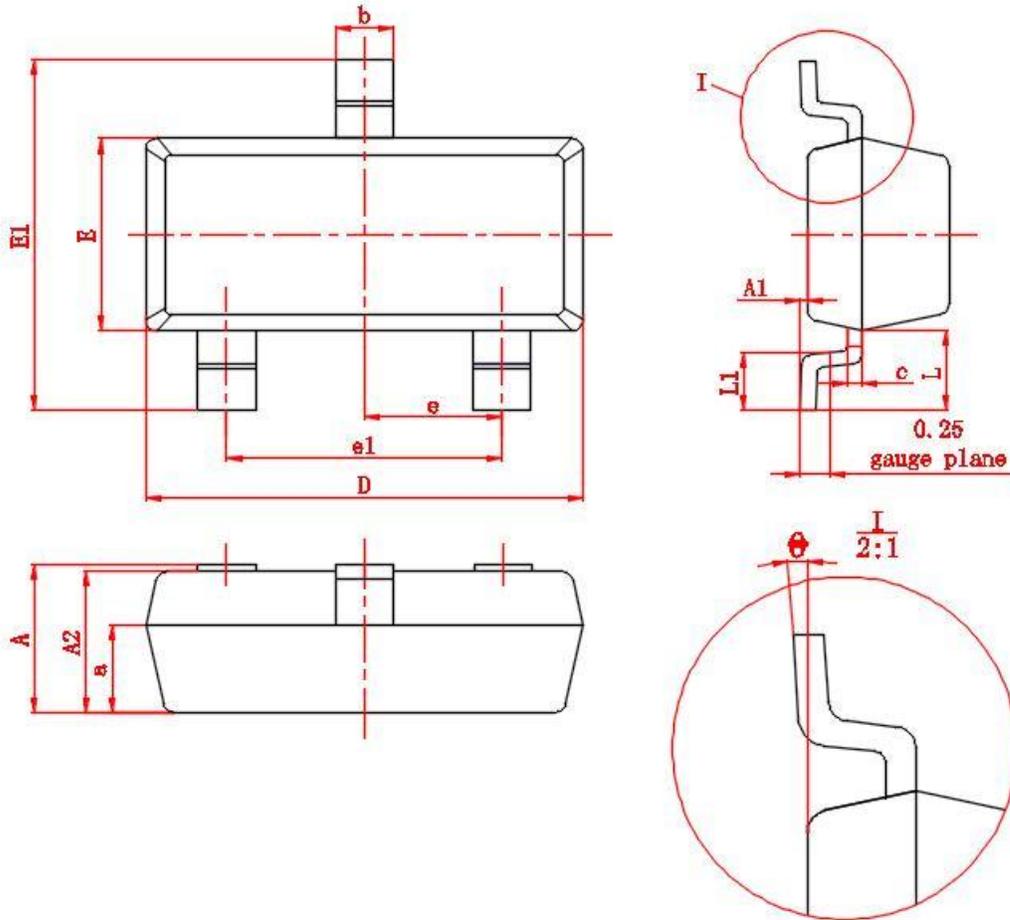
 (T_A=25°C Unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static						
V _{(BR)DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250uA	100			V
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250uA	1	1.6	2.5	V
I _{GSS}	Gate Leakage Current	V _{DS} =0V, V _{GS} =±20V			±100	nA
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =100V, V _{GS} =0V			1	uA
R _{DS(on)}	Drain-Source On-Resistance	V _{GS} =10V, I _D =2A		220	286	mΩ
		V _{GS} =4.5V, I _D =1A		235	330	
Dynamic						
g _{fs}	Forward Transconductance	V _{DS} =15V, I _D =3.2A		5		S
C _{iss}	Input Capacitance	V _{DS} =50V, V _{GS} =5V, f=1MHz		405		pF
C _{oss}	Output Capacitance			28.2		
C _{rss}	Reverse Transfer Capacitance			14.2		
Q _g	Total Gate Charge	V _{DS} =50V, V _{GS} =10V, I _D =1.2A		7.7		nC
Q _{gs}	Gate-Source Charge			1.8		
Q _{gd}	Gate-Drain Charge			2.1		
t _{d(on)}	Turn-On Time	V _{DS} =30V, V _{GS} =10V, I _D =1.2A, R _G =6Ω		3.4		ns
T _r				2.2		
t _{d(off)}	Turn-Off Time			8		
T _f				3.2		
Body-Diode						
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} =0V, I _S =3.2A			0.95	V
t _{rr}	Body Diode Reverse Recovery Time	I _S =3.2A, di/dt=100A/us		27		ns
Q _{rr}	Body Diode Reverse Recovery Charge	I _S =3.2A, di/dt=100A/us		32		nC

Typical Performance Characteristics

Fig.1 Typical Output Characteristics(25°C)

Fig.2 Typical Output Characteristics(150°C)

Fig.3 Typical Transfer Characteristics

Fig.4 On-Resistance vs. Drain Current

Fig.5 Normalised Curves vs. Junction Temperature

Fig.6 Source-Drain Diode Forward Voltage

Typical Performance Characteristics

Fig.7 Maximum P_D vs. Case Temperature

Fig.8 Pulse Power Dissipation

Fig.9 Capacitance Characteristics

Fig.10 Typical Gate Charge vs. Gate-Source Voltage

Fig.11 Safe Operating Area

Fig.12 Transient Thermal Impedance

Typical Characteristics
Gate Charge Test Circuit & Waveform

Resistive Switching Test Circuit & Waveforms

Unclamped Inductive Switching Test Circuit & Waveforms


Package Dimension(Units:mm)
SOT-23


Symbol	Min	Max	Symbol	Min	Max
A	0.90	1.15	e	0.95 BSC	
A1	0	0.10	e1	1.80	2.00
A2	0.90	1.05	b	0.30	0.50
a	0.60 BSC		c	0.08	0.15
D	2.80	3.00	L	0.55 BSC	
E	1.20	1.40	L1	0.30	0.50
E1	2.25	2.55	θ	0°	8°